

Double-Slit Experiment

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Abstract

When two narrow beams of light at the same phase angle are projected on a screen, they interfere and create the fringes of light shown in Fig.1. This phenomenon shows the wave nature of light. Originally done by Young back in 1800, the double-slit experiment was reproduced in this lab with the use of the TWS apparatus with a laser of 670nm in wavelength. The monochromatic light beam was sent from one end of a u-channel through a double-slit to create an interference pattern that was detected by a photodiode at the other end. The observed interference pattern is fitted using Fraunhofer model, which describes far-field diffraction. The amplitude of the double-slit pattern was observed to be the modulated by the single slit diffraction pattern. Reduced χ^2 of the double-slit fit curve is 0.827 and that of the single-slit fit curve is 1.57, both indicating that the data are consistent with the model within our estimate of uncertainty.

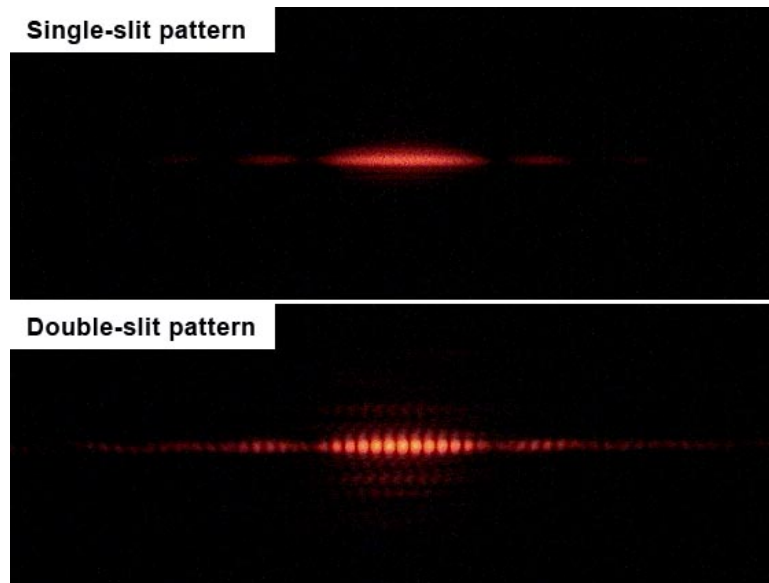


FIG. 1. Single and double-slit interference patterns¹.

I. INTRODUCTION

The double-slit experiment, also known as the Young's experiment, explores the wave-like nature of light. It is important in this experiment for the two sources of light are coherent and have the same phase. Back in 1801, Thomas Young had difficulty with using common light sources, such as candles and lanterns, to be served as coherent sources of light. Thus instead, Young performed the experiment by filtering sunlight through a pinhole in a window shutter split by a piece of card and projecting it horizontally across the room. Light waves from either side of the card coming through the pinhole can be thus considered coherent sources and the interference pattern was then projected onto a screen from which the wavelength of the light source could be determined using Young's Equation:

$$\lambda = \frac{yd}{mL}$$

Today, we can do the experiment by using the TWS apparatus that includes a monochromatic laser beam at one end (with a wavelength of 670 nm) passing through a double slit all encapsulated in a tightly sealed u-channel. Adjusting the micrometer attached to the detector-slit allows you to gather information regarding the interference pattern that is projected to a photodiode at the other end of the u-channel.

II. EXPERIMENT

In this experiment, the apparatus is set up as shown in Fig. 2. After precise alignment of the laser, the double-slit, the slit-blocker, and the detector-slit, the photodiode is connected to a multimeter which is ultimately connected to the computer. LabView is used to collect data first for the double-slit experiment and for the single-slit experiment.

All parts are carefully aligned and key positions of the slit-blocker are recorded, so that light from one or two slits could be blocked and form both double-slit and single-slit interference patterns. The shutter at the end of the U-channel was kept closed, because only the photodiode on the surface of the shutter is used. After the preparation work, the double-slit experiment is first performed. A double-slit of slit width approximately 0.1 mm and slit separation 0.406 mm is used.

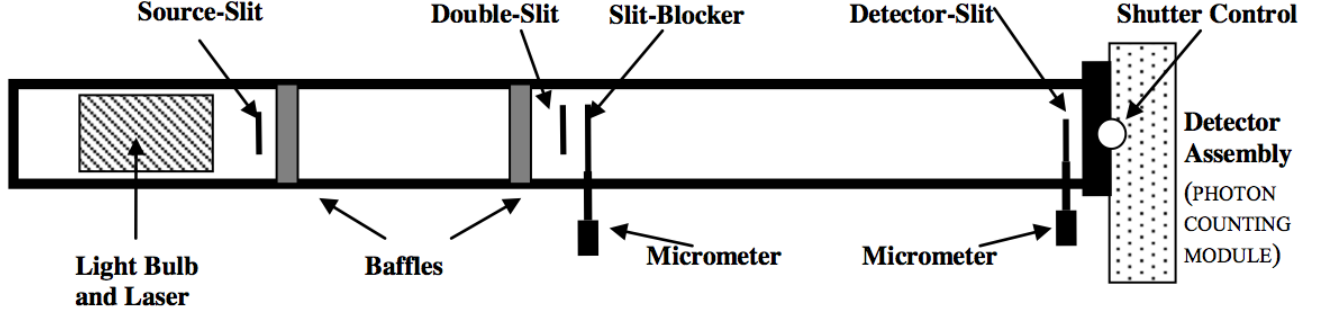


FIG. 2. Schematic of TWS apparatus - not to scale².

The slit-blocker is set at the position where light from both slits are allowed to pass, and the detector-slit is set at the position of the central maximum. The photodiode outputs a voltage that is proportional to the intensity of the laser beam.

By changing the position of the detector-slit, intensity of the laser light is recorded by LabView as a function of location. Then the experiment is repeated for single-slit when the slit-blocker blocks light from one of the two slits.

III. RESULTS

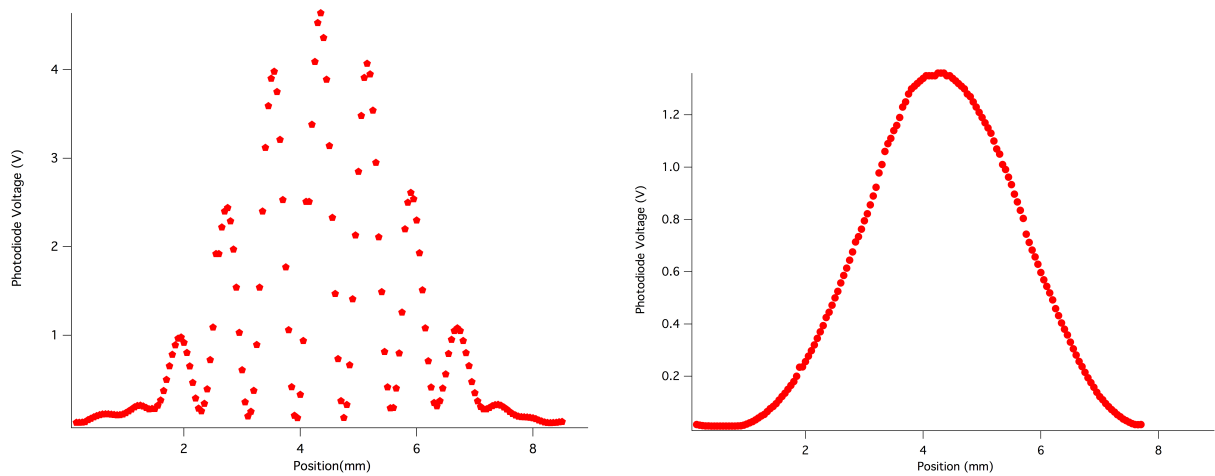


FIG. 3. Recorded data for double (left) and single-slit (right) interference experiments.

The recorded raw data for the double and single-slit experiments are shown in Fig.3. First looking at the double slit experiment, to create the curve of best fit, the Fraunhofer equation is applied to the double-slit intensity:

$$I = I_0 \text{sinc}^2\left(\frac{\pi a}{\lambda} \sin\theta\right) \cos^2\left(\frac{\pi d}{\lambda} \sin\theta\right) \quad (1)$$

Using plotting tools in Igor while applying Eq. 1, we can obtain the plot shown below in Fig. 4. Calculation of the error bars will be included in the discussion section.

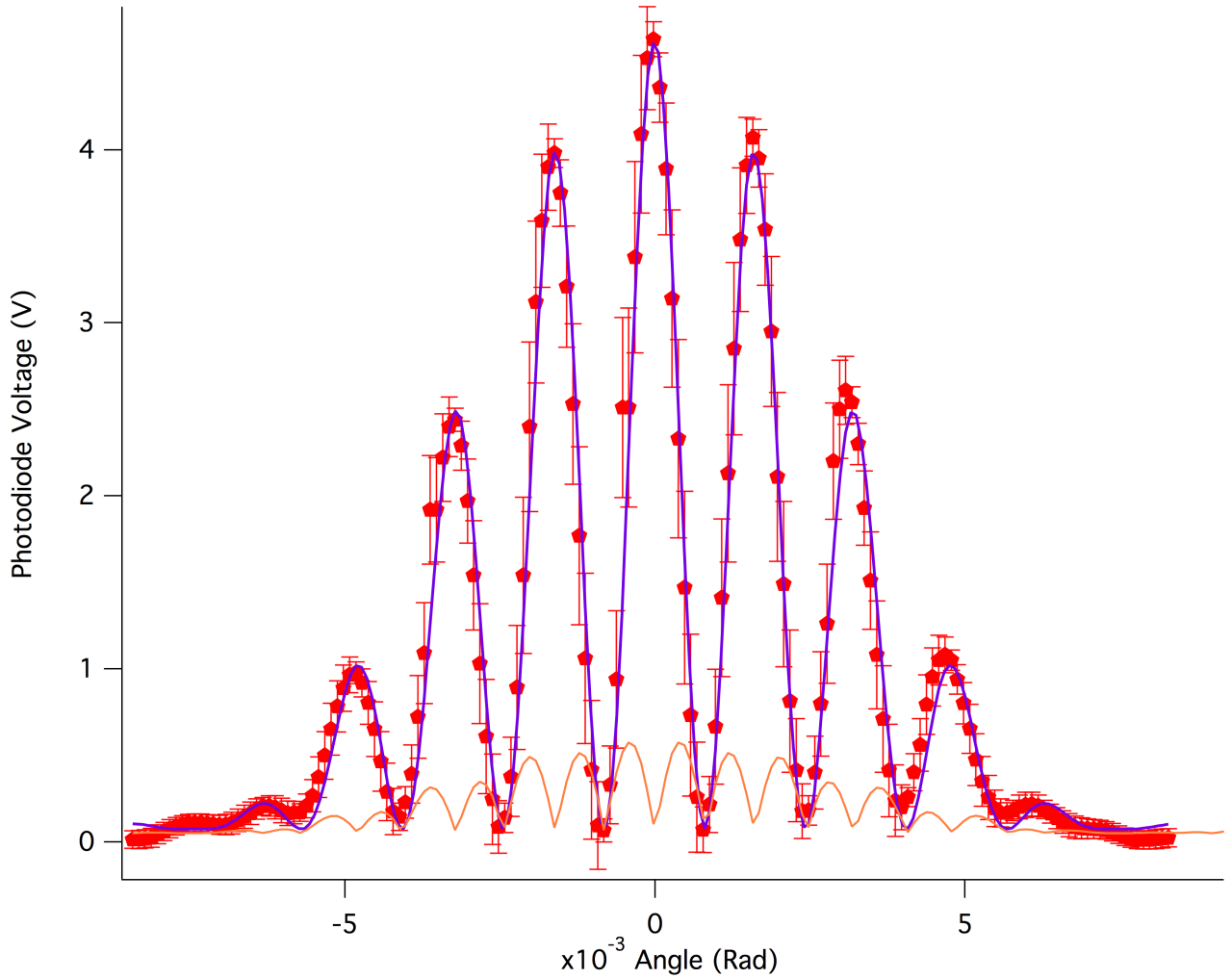


FIG. 4. Plot of raw data, error bars and fit curve of the double-slit experiment. The y-axis is the voltage the photodiode outputs which is proportional to the intensity of light shining on it, and the x-axis is the angle away from the central maximum (Fig. 5). The curve at the bottom of the graph shows the size of error as a function of angle.

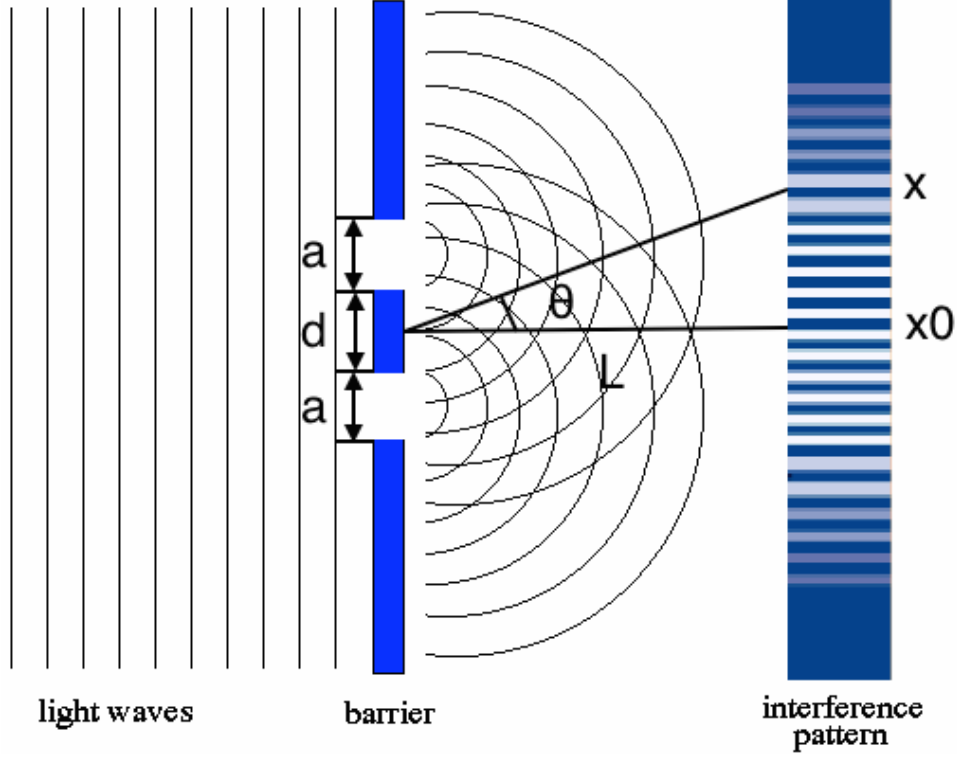


FIG. 5. Calculate angle from position³

TABLE I. Double-slit data

Name	Symbol	Value	Uncertainties(\pm)
Slit width	a	$88.3 \mu m$	$0.4 \mu m$
Slit separation	d	$426.89 \mu m$	$0.07 \mu m$
Wavelength	λ	0.67 nm	N/A
Max voltage	V_0	4.55 V	0.07 V
Voltage offset	V_{offset}	0.073 V	0.008 V
Theta offset	θ_{offset}	$1\text{E-}05 \text{ rad}$	$8\text{E-}06 \text{ rad}$
Chi Squared	X^2	0.827068	

The Fraunhofer conditions can be applied once again to create the curve of best fit for the single-slit experiment:

$$I = I_0 \text{sinc}^2\left(\frac{\pi a}{\lambda} \sin\theta\right) \quad (2)$$

Using plotting tools in Igor while applying Eq.2, we can obtain the plot shown in Fig.6. Calculation of the error bars will be once again included in the discussion section for the

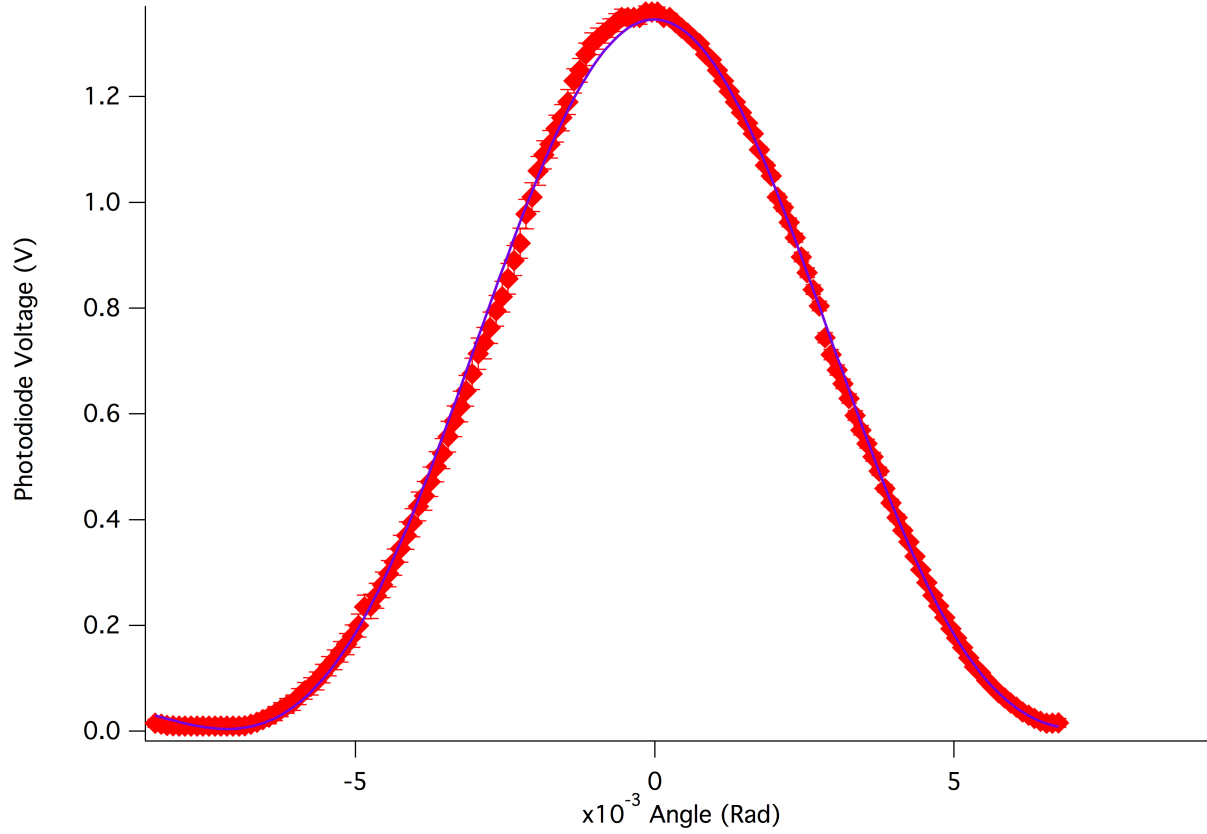


FIG. 6. Plot of raw data, error bars and fit curve of the single-slit experiment. The y-axis is still the output voltage of the photodiode, and the x-axis is the angle away from the central maximum.

single slit experiment.

TABLE II. Single-slit data

Name	Symbol	Value	Uncertainties(\pm)
Slit width	a	$93.9 \mu m$	$0.2 \mu m$
Wavelength	λ	0.67 nm	N/A
Max voltage	V_0	1.350 V	0.002 V
Voltage offset	V_{offset}	0.004 V	0.001 V
Theta offset	θ_{offset}	$1\text{E-}05 \text{ rad}$	$7\text{E-}06 \text{ rad}$
Chi Squared	χ^2	1.56815	

IV. DISCUSSION

A. Double-Slit Experiment

The Fraunhofer/Fresnel theory (Eq.1) of interference gives the intensity of light as a function of angle. The photodiode we use to conduct the experiment outputs a voltage proportional to the intensity of light detected ($I = kV$), thus the intensity measurements can be replaced by the voltage readings and the analysis holds for both:

$$V = V_0 \text{sinc}^2\left(\frac{\pi a}{\lambda} \sin(\theta + \theta_{offset})\right) \cos^2\left(\frac{\pi d}{\lambda} \sin(\theta + \theta_{offset})\right) + V_{offset} \quad (3)$$

Several parameters are added to the original Fraunhofer model. V_{offset} is describing the affect of the background light. Although the photodiode is kept in a closed black box, there is a slight amount of background light, which will produce an offset and shift the whole curve up. θ_{offset} describes the systematic error in angle, which is a result of the systematic error in position.

Some other parameters need fitting are slit width and slit separation. Due to manufacturing imperfection, the slit width and slit separation have slightly different values than given by the experiment manual. The wavelength of the laser might also be slightly off, but because equation m contains ratio terms $\frac{\pi a}{\lambda}$ and $\frac{\pi d}{\lambda}$, the numerator and denominator cannot change at the same time. Compared to a and d , λ is less likely to have a greatly different value, so it is held at $0.67 \mu m$. V_0 stands for the voltage measured at the central maximum.

Uncertainty in the variable (angle θ) is determined by applying error propagation. Each step of the detector-slit change is designed to be 0.05 mm on the micrometer, from $x_i = 0.15 \text{ mm}$ to $x_f = 8.35 \text{ mm}$. Angle θ corresponds to the position in radian (Fig. 5) is given by

$$\theta = \frac{\arctan(x - x_0)}{D} \quad (4)$$

D is the distance from the double-slit to the photodiode, is 50 cm given by the experiment manual. x_0 is found to be $4.4 \pm 0.1 \text{ mm}$ given by the Gaussian curve fit to the data set.

However, due to human error, each step is not perfectly 0.05 mm , but $0.05 \pm 0.03 \text{ mm}$. Then the error in angle is given by taking derivative of Eq. 4 and multiply θ' by δx , which is 0.03 mm .

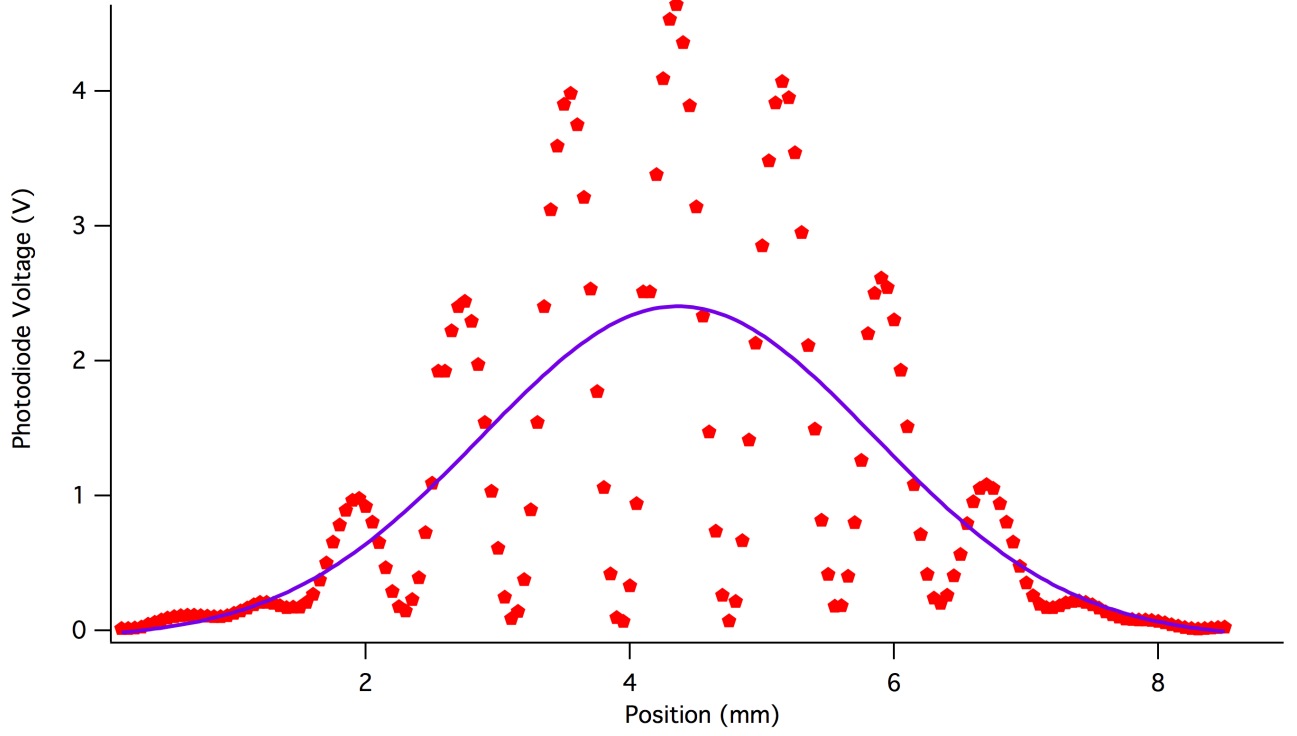


FIG. 7. Gaussian curve fit of double-slit interference is made to find the position where the intensity/output voltage of the photodiode peaks.

$$\theta' = \frac{1}{D(1 + (x - x_0)^2)} \quad (5)$$

$$\delta\theta = \theta' \delta x = \frac{\delta x}{D(1 + (x - x_0)^2)} \quad (6)$$

$\delta\theta$ is a function of position x . The same method of taking derivative could be applied to find the error in voltage, but it is rather messy. So a different approach is adopted to find δV , which is to change θ in Eq. 3 by $\delta\theta$ and calculate the resulting change in V , which is then divided by 2.

$$\delta V = \frac{|V(\theta + \delta\theta) - V(\theta - \delta\theta)|}{2} \quad (7)$$

It can be seen that the same $\delta\theta$ has a smaller impact on δV when V' is small, and a bigger impact when V' is big.

The multimeter itself also contributes to the error in angle. We estimate the error in meter readings to be $0.05v$. So the overall δV is

$$\delta V_{total} = \delta V + \delta V_{meter} = \delta V + 0.05v \quad (8)$$

δV is plotted as a function of angle in Fig. 4.

The reduced χ^2 is calculated for the fit curve, yielding a value of 0.827. The value is close to 1, meaning that the fit is good within estimation of error.

B. Single-Slit Experiment

The intensity of light as a function of θ in single-slit experiment is given by the Fraunhofer/Fresnel theory in Eq. 2, which can then be transformed as

$$V = V_0 \cos^2\left(\frac{\pi d}{\lambda} \sin(\theta + \theta_{offset})\right) + V_{offset} \quad (9)$$

Parameters need fitting are slit width (a), slit separation (d), maximal voltage (V_0), offset in voltage (V_{offset}) due to background light, and offset in θ (θ_{offset}) due to systematic error of position.

Uncertainty is determined using the same method. θ is found using Eq. 4 while x goes from $x_i = 0.15mm$ to $x_f = 7.7mm$ with a step size of $0.05mm$. However, the value of x_0 need re-calculating, since the single-slit pattern is slightly shifted than the double-slit pattern. A Gaussian fit is done to the data to determine x_{offset} , which is $4.327 \pm 0.003mm$.

Distance remains as $50cm$. Uncertainty in step size is also considered to be $0.03mm$, as in the double-slit experiment. Eq. 5, 6 and 7 are used to determine uncertainty in voltage. In the final step of calculating δV_{total} (Eq. 8), δV_{meter} is changed to $0.01v$, because the single-slit pattern has smaller intensity and thus a fluctuation of smaller scale in voltage.

The reduces χ^2 is 1.56815, which is approximately 1, showing the fit is good within our estimate of error.

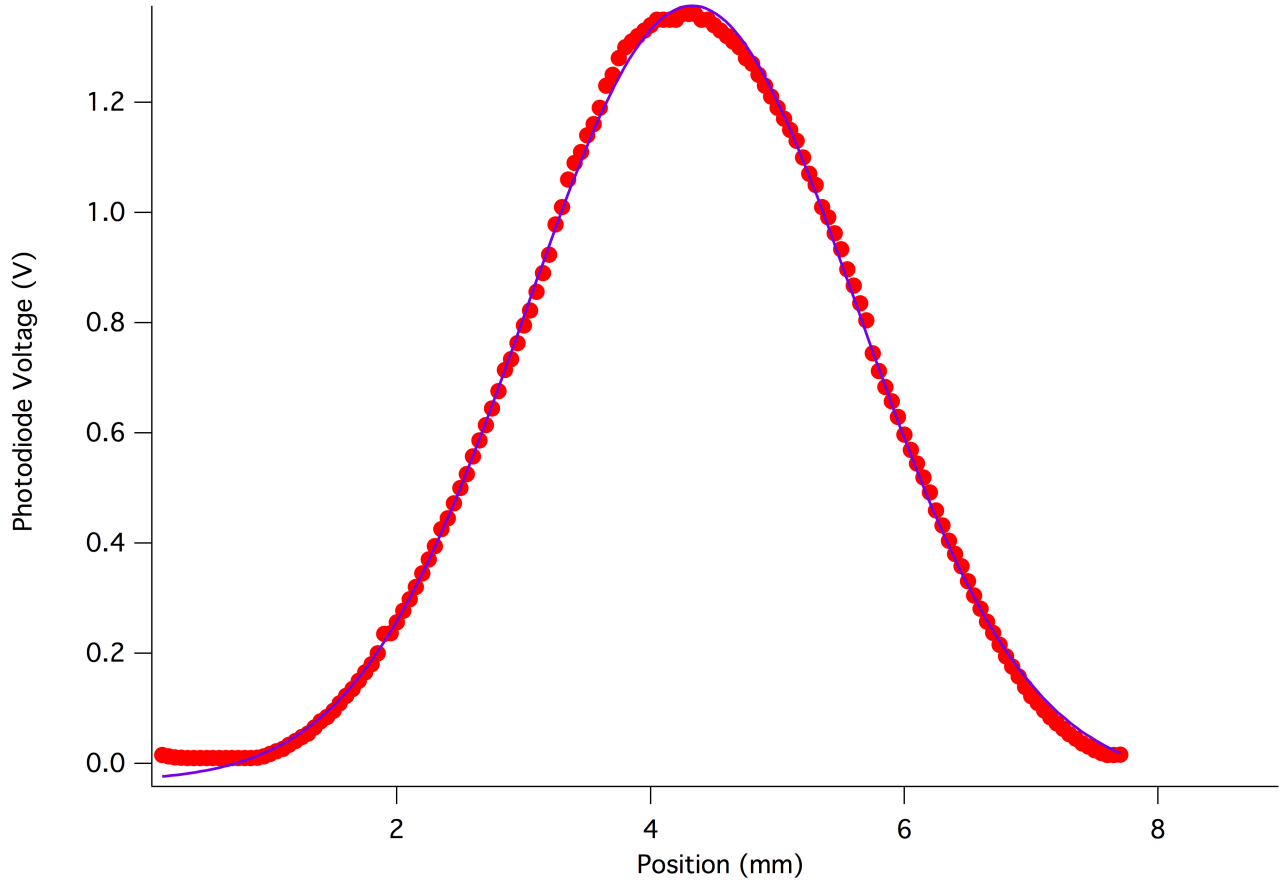


FIG. 8. Gaussian curve fit of single-slit diffraction is made to find the position where intensity/output voltage of the photodiode peaks.

C. Comparison

Looking at parts A and B, we see that the the maximum voltage (V_0) for the double-slit is approximately 4 times the maximum voltage for the single-slit equation. This is because when two central maximums of the two slits are superposed, the amplitude doubles at the central maximum ($\theta = 0$). The intensity is proportional to the amplitude squared:

$$I \propto A^2 \quad 4I \propto (2A)^2$$

This relationship is clearly shown in our experiment:

$$\frac{V_{0,double}}{V_{0,single}} = \frac{A_{0,double}^2}{A_{0,single}^2} = \frac{4.55 \pm 0.07}{1.350 \pm 0.002} = 3.37 \pm 0.06 \approx 4$$

As we can see, the Voltage double slit quadrupled.

V. CONCLUSION

The observed interference pattern is fitted using Fraunhofer model, which describes far-field diffraction. The amplitude of the double-slit pattern was observed to be modulated by the single slit diffraction pattern. Reduced χ^2 of the double-slit fit curve is 0.827 and that of the single-slit fit curve is 1.57.

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¹ Double Slit Experiment, <http://upload.wikimedia.org/wikipedia/commons/c/c2/Single_slit_and_double_slit2.jpg/>.

² TeachSpin Instructions Manual, *Two-Slit interference, One Photon at a Time (TWS1-B)*, *Pulse Counter/Interval Timer (PCIT1)*, 6/2013.

³ Young Two-Slit Experiment, http://abyss.uoregon.edu/~js/21st_century_science/lectures/lec13.html